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**ON Semiconductor®** 

# FDS8958A-F085

# Dual N & P-Channel PowerTrench® MOSFET

## **General Description**

These dual N- and P-Channel enhancement mode power field effect transistors are produced using ON Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state ressitance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.



# Features

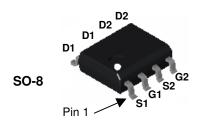
- Q2: P-Channel

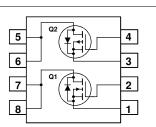
 $\begin{array}{ll} 5 \text{A}, \ -30 \text{V} & \text{R}_{\text{DS(on)}} = 0.052 \Omega \ @ \text{V}_{\text{GS}} = -10 \text{V} \\ \hline & \text{R}_{\text{DS(on)}} = 0.080 \Omega \ @ \text{V}_{\text{GS}} = -4.5 \text{V} \end{array}$ 

Fast switching speed

High power and handling capability in a widely used surface mount package

- Qualified to AEC Q101
- RoHS Compliant





### **Absolute Maximum Ratings** $T_{A} = 25^{\circ} C$ unless otherwise noted

Symbol	Parameter		Q1	Q2	Units	
V <sub>DSS</sub>	Drain-Source Voltage		30	30	V	
V <sub>GSS</sub>	Gate-Source Voltage		±20	±20	V	
ID	Drain Current - Continuous	(Note 1a)	7	-5		
	- Pulsed		20	-20	A	
PD	Power Dissipation for Dual Operation		2	2		
	Power Dissipation for Single Operation	(Note 1a)	1.6	1.6	W	
		(Note 1c)	0.9	0.9		
E <sub>AS</sub>	Single Pulse Avalanche Energy	(Note 3)	54	13	mJ	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperatu	ire Range	-55 to +150		°C	
Therma	I Characteristics					
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78		°C/W	
R <sub>eJC</sub>	Thermal Resistance, Junction-to-Case	(Note 1)	40		°C/W	

Device Marking	Device	Reel Size	Tape width	Quantity
FDS8958A	FDS8958A-F085	13"	12mm	2500 units

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Publication Order Number: FDS8958A-F085/D

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Cha	racteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage		Q1 Q2	30 -30			V
<u>ΔBVdss</u> ΔTj	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25°C $I_D = -250 \ \mu$ A, Referenced to 25°C	Q1 Q2		25 -23		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current		Q1 Q2			1 -1	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	$V_{GS} = 20 \text{ V}, \qquad V_{DS} = 0 \text{ V}$	All			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, \qquad V_{DS} = 0 \text{ V}$	All			-100	nA
On Cha	racteristics (Note 2)						
$V_{GS(th)}$	Gate Threshold Voltage	$ \begin{array}{ll} V_{DS} = V_{GS}, & I_{D} = 250 \; \mu A \\ V_{DS} = V_{GS}, & I_{D} = -250 \; \mu A \end{array} $	Q1 Q2	1 -1	1.9 -1.7	3 -3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25°C $I_D = -250 \ \mu$ A, Referenced to 25°C	Q1 Q2		-4.5 4.5		mV/°C
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$ \begin{array}{ll} V_{GS} = 10 \ V, & I_D = 7 \ A \\ V_{GS} = 10 \ V, & I_D = 7 \ A, \ T_J = 125^\circ C \\ V_{GS} = 4.5 \ V, & I_D = 6 \ A \end{array} $	Q1		19 27 24	28 42 40	mΩ
		$ \begin{array}{ll} V_{GS} = -10 \ V, & I_D = -5 \ A \\ V_{GS} = -10 \ V, \ I_D = -5 \ A, \ T_J = 125^\circ C \\ V_{GS} = -4.5 \ V, & I_D = -4 \ A \\ V_{GS} = 10 \ V, & V_{DS} = 5 \ V \end{array} $	Q2		42 57 65	52 78 80	
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = -10 \text{ V}, \qquad V_{DS} = -5 \text{ V}$	Q1 Q2	20 -20			A
<b>g</b> fs	Forward Transconductance		Q1 Q2		25 10		S
Dynami	c Characteristics						
C <sub>iss</sub>	Input Capacitance	Q1 V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz	Q1 Q2		575 528		pF
C <sub>oss</sub>	Output Capacitance	Q2	Q1 Q2		145 132		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	$V_{DS} = -15 V$ , $V_{GS} = 0 V$ , f = 1.0 MHz	Q1 Q2		65 70		pF
R <sub>G</sub>	Gate Resistance	$V_{GS} = 15 \text{ mV}, \qquad f = 1.0 \text{ MHz}$	Q1 Q2		2.1 6.0		Ω

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Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Switchi	ng Characteristics (Note	2)					
t <sub>d(on)</sub>	Turn-On Delay Time	Q1	Q1		8	16	ns
		$V_{DD} = 15 \text{ V}, \text{ I}_{D} = 1 \text{ A},$	Q2		7	14	
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = 10V, R_{GEN} = 6 \Omega$	Q1 Q2		5 13	10 24	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	Q2	Q2 Q1		23	37	ns
Ld(off)	Turn-On Delay Time	$V_{DD} = -15 \text{ V}, \text{ I}_{D} = -1 \text{ A},$	Q2		14	25	113
tr	Turn-Off Fall Time	$V_{GS} = -10V, R_{GEN} = 6 \Omega$	Q1		3	6	ns
•1			Q2		9	17	
Qa	Total Gate Charge	Q1	Q1		11.4	16	nC
5	C C	$V_{DS} = 15 \text{ V}, I_D = 7 \text{ A}, V_{GS} = 10 \text{ V}$	Q2		9.6	13	
Q <sub>gs</sub>	Gate-Source Charge		Q1		1.7		nC
		Q2	Q2		2.2		
Q <sub>gd</sub>	Gate-Drain Charge	$V_{DS} = -15 \text{ V}, \text{ I}_{D} = -5 \text{ A}, \text{V}_{GS} = -10 \text{ V}$	Q1		2.1		nC
			Q2		1.7		
Drain-S	ource Diode Character	istics and Maximum Rating	S				
ls	Maximum Continuous Drain-Source Diode Forward Current					1.3	Α
-			Q2			-1.3	
SM Maximum Plused Drain-Source		ce Diode Forward Current (Note 2)	Q1			20	Α
		1	Q2			-20	
V <sub>SD</sub>	Drain-Source Diode Forward	$V_{GS} = 0 V, I_S = 1.3 A$ (Note 2)	Q1		0.75	1.2	V
	Voltage	$V_{GS} = 0 V, I_S = -1.3 A$ (Note 2)	Q2		-0.88	-1.2	
t <sub>rr</sub>	Diode Reverse Recovery		Q1		19		nS
_	Time	$I_F = 7 \text{ A}, d_{iF}/d_t = 100 \text{ A}/\mu \text{s}$	Q2		19		
Q <sub>rr</sub>	Diode Reverse Recovery		Q1		9		nC
	Charge	I <sub>F</sub> = -5 A, d <sub>iF</sub> /d <sub>t</sub> = 100 A/μs	Q2		6	I	

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### Notes:

1.  $R_{0JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{0JC}$  is guaranteed by design while  $R_{0CA}$  is determined by the user's board design.



a) 78°/W when mounted on a 0.5 in<sup>2</sup> pad of 2 oz copper



b) 125°/W when mounted on a .02 in<sup>2</sup> pad of 2 oz copper

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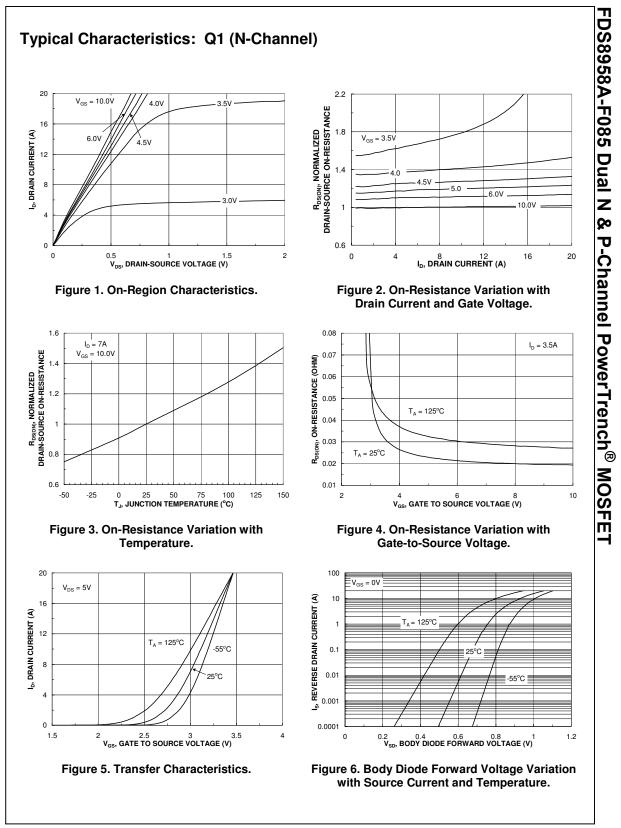
c) 135 % W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

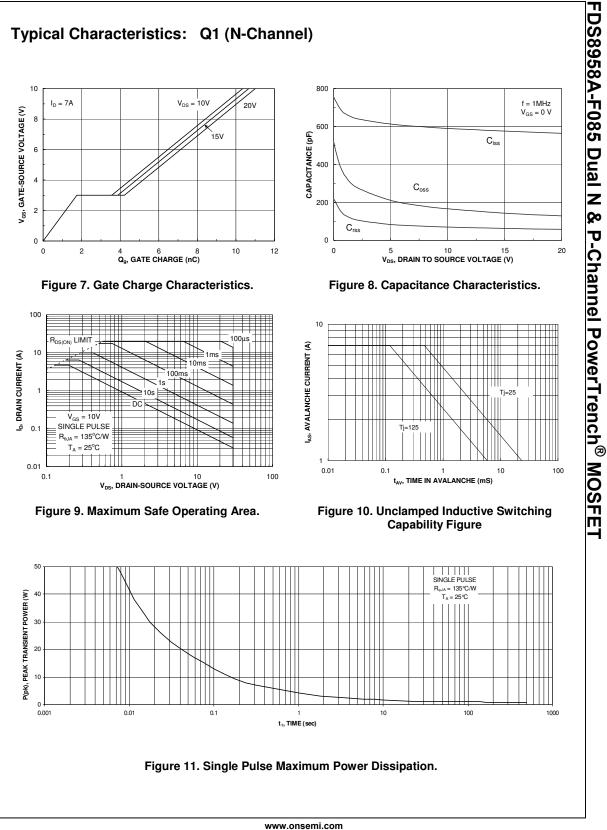
2. Pulse Test: Pulse Width < 300 $\mu$ s, Duty Cycle < 2.0%

3. Starting TJ = 25 °C, L = 3mH,  $I_{AS}$  = 6A,  $V_{DD}$  = 30V,  $V_{GS}$  = 10V (Q1).

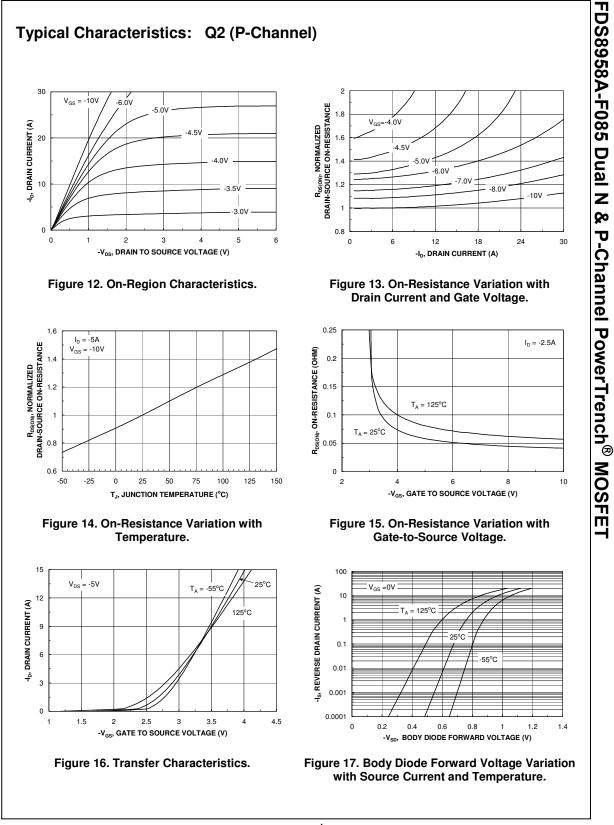
Starting TJ = 25 °C, L = 3mH,  $I_{AS}$  = 3A,  $V_{DD}$  = 30V,  $V_{GS}$  = 10V (Q2).



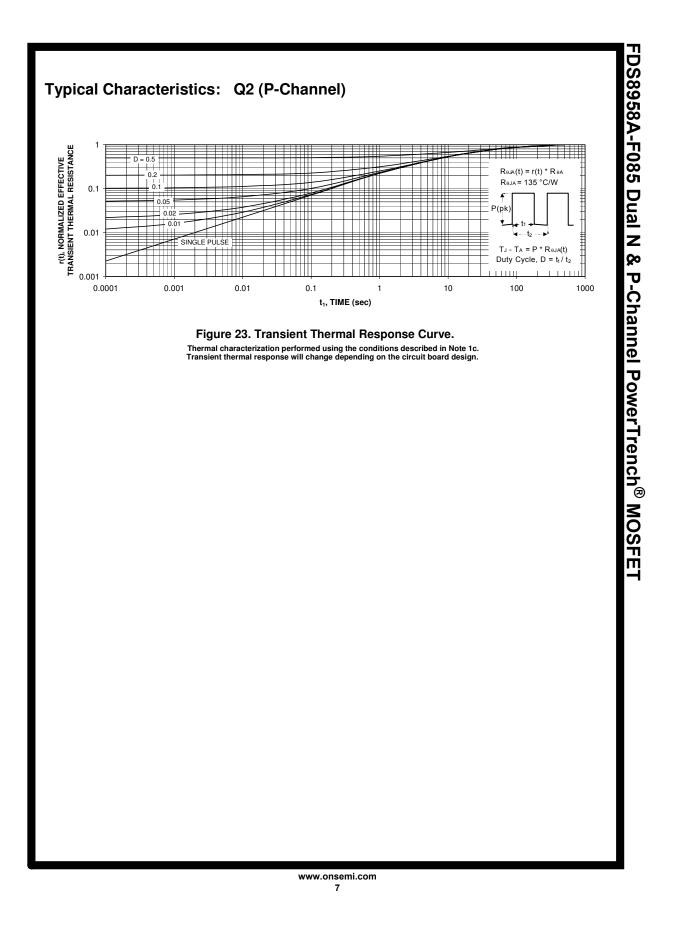
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